PowerPhase, Dual N-Channel SO8FL 30 V. High Side 20 A / Low Side 26 A

Features

- Co-Packaged Power Stage Solution to Minimize Board Space
- Minimized Parasitic Inductances
- Optimized Devices to Reduce Power Losses
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- DC–DC Converters
- System Voltage Rails
- Point of Load

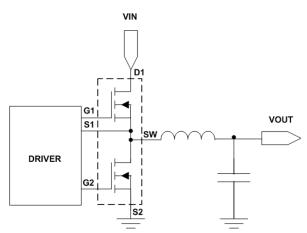
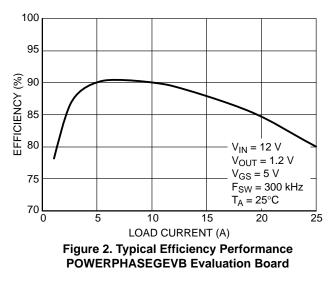


Figure 1. Typical Application Circuit

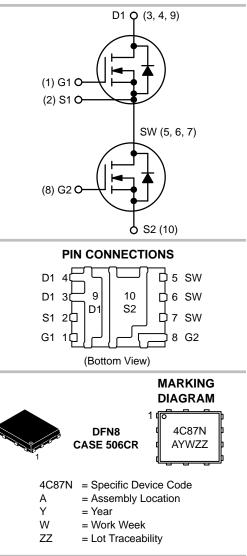




ON Semiconductor®

www.onsemi.com

| V _{(BR)DSS} | R _{DS(ON)} MAX | I _D MAX |
|----------------------|-------------------------|--------------------|
| Q1 Top FET | 5.4 mΩ @ 10 V | 20.4 |
| 30 V | 8.1 mΩ @ 4.5 V | 20 A |
| Q2 Bottom | 3.1 mΩ @ 10 V | 26 A |
| FET 30 V | 4.3 mΩ @ 4.5 V | 20 A |



ORDERING INFORMATION

See detailed ordering and shipping information on page 10 of this data sheet.

MAXIMUM RATINGS ($T_J = 25^{\circ}C$ unless otherwise stated)

| Parameter | | Symbol | Value | Unit | | |
|-------------------------------------------------------------------------------------------------------------------------------|----------|------------------------|-------|-----------------------------------|-------------|------|
| Drain-to-Source Voltage | Q1 | V _{DSS} | 30 | V | | |
| Drain-to-Source Voltage | Q2 | | | | | |
| Gate-to-Source Voltage | | | Q1 | V _{GS} | ±20 | V |
| Gate-to-Source Voltage | | | Q2 | | | |
| Continuous Drain Current $R_{\theta JA}$ (Note 1) | | $T_A = 25^{\circ}C$ | Q1 | ۱ _D | 15.4 | |
| | | T _A = 85°C | | | 11.1 | |
| | | T _A = 25°C | Q2 | | 19.5 | A |
| | | T _A = 85°C | | | 14.1 | |
| Power Dissipation | | T _A = 25°C | Q1 | PD | 1.89 | W |
| R0JA (Note 1) | | | Q2 | | | |
| Continuous Drain Current $R_{\theta JA} \le 10$ s (Note 1) | | T _A = 25°C | Q1 | ۱ _D | 21.0 | |
| | | T _A = 85°C | | | 15.1 | ^ |
| | Steady | T _A = 25°C | Q2 | | 26.6 | A |
| | State | T _A = 85°C | - | | 19.2 | |
| Power Dissipation $P_{\rm res} < 10.9$ (Note 1) | | T _A = 25°C | Q1 | PD | 3.51 | W |
| $R_{\theta JA} \le 10 \text{ s} (\text{Note 1})$ | | | Q2 | | | |
| Continuous Drain Current | | $T_A = 25^{\circ}C$ | Q1 | Ι _D | 11.7 | |
| R _{θJA} (Note 2) | | $T_A = 85^{\circ}C$ | | | 8.5 | A |
| | | $T_A = 25^{\circ}C$ | Q2 | | 14.9 | |
| | | $T_A = 85^{\circ}C$ | | | 10.7 | |
| Power Dissipation | | T _A = 25 °C | Q1 | PD | 1.10 | W |
| R _{θJA} (Note 2) | | | Q2 | | | |
| Pulsed Drain Current | | $T_A = 25^{\circ}C$ | Q1 | I _{DM} | 160 | А |
| | | t _p = 10 μs | Q2 | | 260 | |
| Operating Junction and Storage Temperature | | | Q1 | T _J , T _{STG} | -55 to +150 | °C |
| | | | Q2 | | | |
| Source Current (Body Diode) | Q1 | I _S | 10 | А | | |
| | Q2 | | 10 | | | |
| Drain to Source DV/DT | | | | dV/dt | 6 | V/ns |
| Single Pulse Drain–to–Source Avalanche Energy (T V_{DD} = 50 V, V_{GS} = 10 V, L = 0.1 mH, R _G = 25 Ω) | J = 25C, | $I_L = 20 A_{pk}$ | Q1 | EAS | 20 | mJ |
| $v_{DD} = 30 v, v_{GS} = 10 v, L = 0.1 \text{ mm}, K_G = 25 \Omega$ | | $I_L = 30 A_{pk}$ | Q2 | EAS | 45 | |
| Lead Temperature for Soldering Purposes (1/8" from case for 10 s) | | | | ΤL | 260 | °C |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.
Surface-mounted on FR4 board using 1 sq-in pad, 2 oz Cu.
Surface-mounted on FR4 board using the minimum recommended pad size of 100 mm².

THERMAL RESISTANCE MAXIMUM RATINGS

| Parameter | Symbol | Value | Unit |
|------------------------------------------------|-----------------|-------|------|
| Junction-to-Ambient - Steady State (Note 3) | R_{\thetaJA} | 66.0 | |
| Junction-to-Ambient - Steady State (Note 4) | $R_{\theta JA}$ | 113.7 | °C/W |
| Junction–to–Ambient – (t \leq 10 s) (Note 3) | R_{\thetaJA} | 35.6 | |

3. Surface-mounted on FR4 board using 1 sq-in pad, 2 oz Cu.

4. Surface-mounted on FR4 board using the minimum recommended pad size of 100 mm².

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise specified)

| Parameter | FET | Symbol | Test Co | ondition | Min | Тур | Max | Unit |
|-----------------------------------------|-----|------------------------------------------|--------------------------------------------------|-------------------------|-----|------|-----|------|
| OFF CHARACTERISTICS | | | | | | | | |
| Drain-to-Source Break- | Q1 | | | 050 4 | 30 | | | V |
| down Voltage | Q2 | V _{(BR)DSS} | $V_{GS} = 0 V,$ | I _D = 250 μA | 30 | | | |
| Drain-to-Source Break- | Q1 | V(BR)DSS | | | | 15.8 | | mV / |
| down Voltage Temperature Coefficient | Q2 | V _{(BR)DSS} / T _J | | | | 15.3 | | °C |
| Zero Gate Voltage Drain | Q1 | I _{DSS} | V _{GS} = 0 V, V _{DS} = 24 V | $T_J = 25^{\circ}C$ | | | 1 | |
| Current | | | $V_{DS} = 24 V$ | T _J = 125°C | | | 10 | μA |
| | Q2 | | V _{GS} = 0 V, V _{DS} = 24 V | $T_J = 25^{\circ}C$ | | | 1 | pu i |
| Gate-to-Source Leakage | Q1 | I _{GSS} | V _{GS} = 0 V, \ | /DS = ±20 V | | | 100 | ~ ^ |
| Current | Q2 | | | | | | 100 | nA |

ON CHARACTERISTICS (Note 5)

| Gate Threshold Voltage | Q1 | V _{GS(TH)} | V _{GS} = VDS, | I _D = 250 μA | 1.3 | | 2.2 | N/ |
|-------------------------------------------------|----|-----------------------|-------------------------|-------------------------|-----|-----|-----|------|
| | Q2 | | | | 1.3 | | 2.2 | V |
| Negative Threshold Temper- ature Coefficient | Q1 | V _{GS(TH)} / | | | | 5.0 | | mV / |
| ature Coemcient | Q2 | ١j | | | | 5.1 | | °C |
| Drain-to-Source On Resist- | Q1 | R _{DS(on)} | V _{GS} = 10 V | I _D = 30 A | | 4.3 | 5.4 | |
| ance | | | V _{GS} = 4.5 V | I _D = 18 A | | 6.5 | 8.1 | |
| | Q2 | | V _{GS} = 10 V | I _D = 30 A | | 2.5 | 3.1 | mΩ |
| | | | V _{GS} = 4.5 V | I _D = 30 A | | 3.4 | 4.3 | |

CAPACITANCES

| Input Canaditanaa | Q1 | C | | 1252 | |
|---------------------|----|------------------|--------------------------------------------|------|----|
| Input Capacitance | Q2 | C _{ISS} | | 1939 | |
| Output Capacitance | Q1 | C | | 610 | ۶E |
| Oulput Capacitance | Q2 | C _{OSS} | V_{GS} = 0 V, f = 1 MHz, V_{DS} = 15 V | 1055 | pF |
| Deverse Conseitones | Q1 | 0 | | 129 | |
| Reverse Capacitance | Q2 | C _{RSS} | | 49 | |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

5. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%. 6. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

| Parameter | FET | Symbol | Test Condition | Min | Тур | Max | Unit |
|-----------------------|-----------|---------------------|-------------------------------------------------------------|-----|------|-----|------|
| CHARGES, CAPACITANCE | S & GATE | RESISTANC | E | | | | |
| Total Oata Ohanna | Q1 | 0 | | | 10.9 | | |
| Total Gate Charge | Q2 | Q _{G(TOT)} | | | 13.8 | | |
| Threshold Cate Charge | Q1 | 0 | | | 1.2 | | |
| Threshold Gate Charge | Q2 | Q _{G(TH)} | | | 2.0 | | nC |
| Gate-to-Source Charge | Q1 | 0 | V_{GS} = 4.5 V, V_{DS} = 15 V; I_{D} = 30 A | | 3.4 | | ne |
| Gale-10-Source Charge | Q2 | Q _{GS} | | | 5.5 | | |
| Gate-to-Drain Charge | Q1 | Q _{GD} | | | 5.4 | | |
| Gale-lo-Dialit Charge | Q2 | QGD | | | 3.6 | | |
| Total Gate Charge | Q1 | 0 | V_{GS} = 10 V, V_{DS} = 15 V; I_{D} = 30 A | | 22.2 | | nC |
| Total Gate Charge | Q2 | Q _{G(TOT)} | | | 30.3 | | ne |
| Gate Resistance | Q1 | R _G | T _A = 25°C | | 1.0 | | Ω |
| Gale Resistance | Q2 | | 1 _A = 25 C | | 1.0 | | |
| SWITCHING CHARACTERI | STICS (No | te 6) | | | | | |
| Turn–On Delay Time | Q1 | tuan | | | 8.9 | | |
| Tum-On Delay Time | Q2 | t _{d(ON)} | | | 10.6 | | |
| Rise Time | Q1 | + | | | 21.2 | | |
| Rise fille | Q2 | t _r | V _{GS} = 4.5 V, V _{DS} = 15 V, | | 4.6 | | ns |
| Turn–Off Delay Time | Q1 | t | $I_{\rm D} = 15 \text{A}, \text{R}_{\rm G} = 3.0 \Omega$ | | 15.3 | | 115 |
| Turn-On Delay Time | Q2 | t _{d(OFF)} | | | 21 | | |
| Fall Time | Q1 | t. | | | 4.4 | | |
| | Q2 | чf | t _f | | 4.9 | | |
| SWITCHING CHARACTERI | STICS (No | te 6) | | | | | |
| Turn–On Delay Time | Q1 | tuon | | | 6.7 | | |
| | Q2 | t _{d(ON)} | | | 8.1 | | |
| Rise Time | Q1 | t | | | 19.5 | | |
| Rise Time | Q2 | | | | 15 | |] |

| Rise Time | Q | + | | 13.5 | |
|---------------------|----|---------------------|------------------------------------------------------------------------------------|------|-----|
| Rise Time | Q2 | ۲ | V_{GS} = 10 V, V_{DS} = 15 V, I _D = 15 A, R _G = 3.0 Ω | 15 | ns |
| Turn–Off Delay Time | Q1 | t | $I_{D} = 15 \text{ A}, \text{ R}_{G} = 3.0 \Omega$ | 20.1 | 115 |
| Tum-On Delay Time | Q2 | ^t d(OFF) | | 26.2 | |
| Fall Time | Q1 | + | | 2.8 | |
| | Q2 | чf | | 3.1 | |

DRAIN-SOURCE DIODE CHARACTERISTICS

| | Q1 | | V _{GS} = 0 V, | $T_J = 25^{\circ}C$ | 0.82 | |
|-----------------|----|-----------------|------------------------|----------------------|------|---|
| | QI | M | I _S = 10 A | $T_J = 125^{\circ}C$ | 1.15 | V |
| Forward Voltage | 00 | V _{SD} | V _{GS} = 0 V, | $T_J = 25^{\circ}C$ | 0.8 | v |
| | Q2 | | I _S = 10 A | $T_J = 125^{\circ}C$ | 1.10 | |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

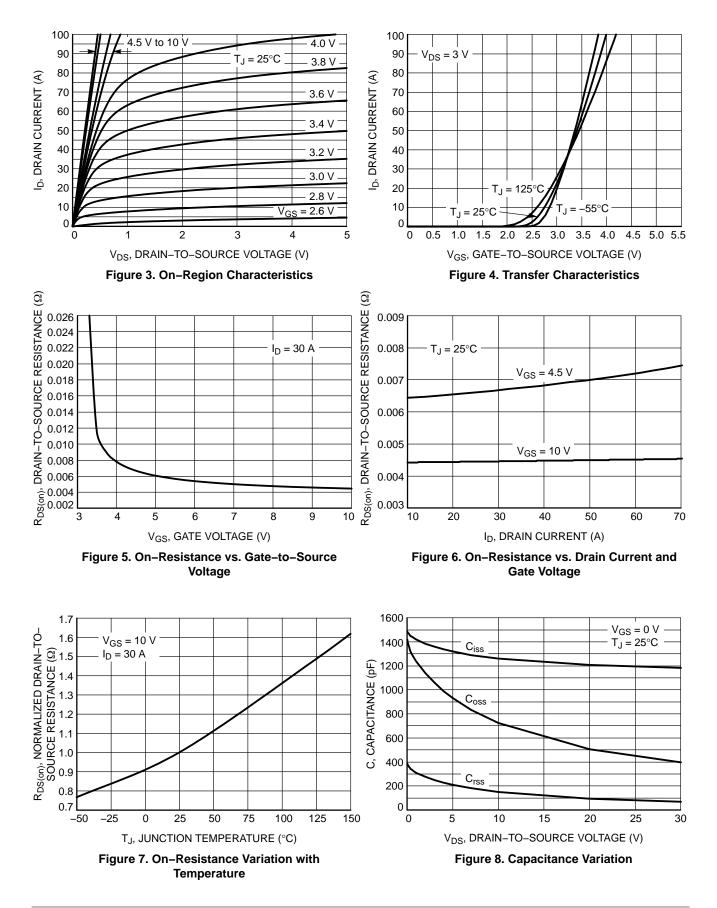
5. Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%. 6. Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise specified)

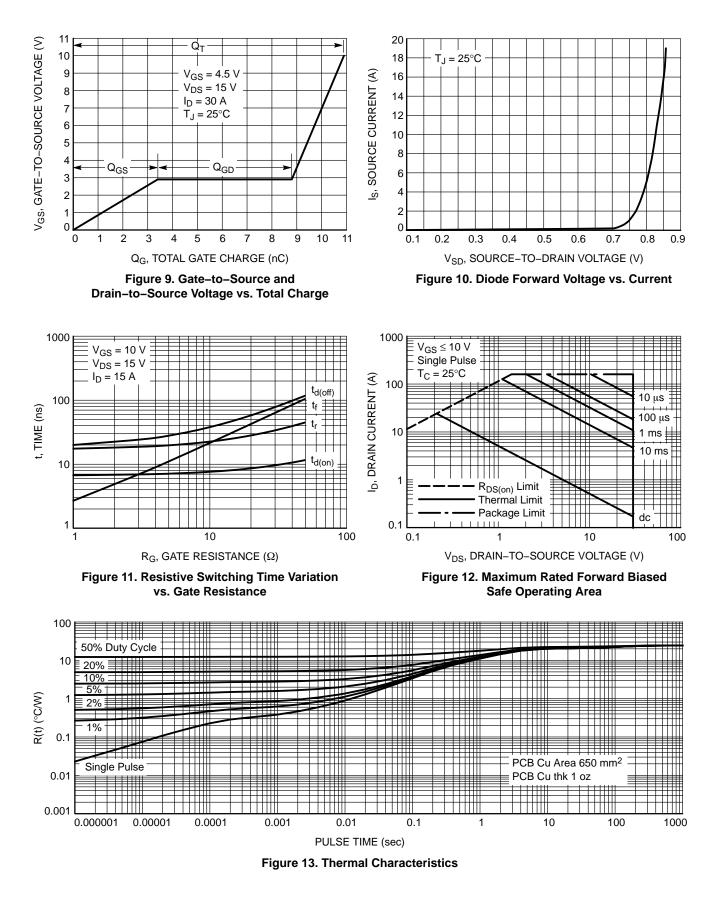
| Parameter | FET | Symbol | Test Condition | Min | Тур | Max | Unit | |
|-------------------------|--------|-----------------|-----------------------------------------------------------------------------------------------------------------|-----|------|------|------|--|
| DRAIN-SOURCE DIODE CH | ARACTE | RISTICS | | | | | | |
| | Q1 | | | | 29.1 | | | |
| Reverse Recovery Time | Q2 | t _{RR} | | | 40.2 | | | |
| Charge Time | Q1 | 4- | to | | | 14.2 | | |
| Charge Time | Q2 | เล | ta $V_{GS} = 0 \text{ V}, \text{ d}_{IS}/\text{d}_t = 100 \text{ A}/\mu\text{s}, \text{ I}_S = 30 \text{ A}$ tb | | 19.5 | | ns | |
| Discharge Time | Q1 | th | | | 14.6 | | | |
| Discharge Time | Q2 | lD | | | 20.6 | | | |
| Deverse Desevery Charge | Q1 | 0 | Q _{RR} | | 21 | | | |
| Reverse Recovery Charge | Q2 | W RR | | | 39 | | nC | |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 5. Pulse Test: pulse width \leq 300 µs, duty cycle \leq 2%. 6. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS – Q1

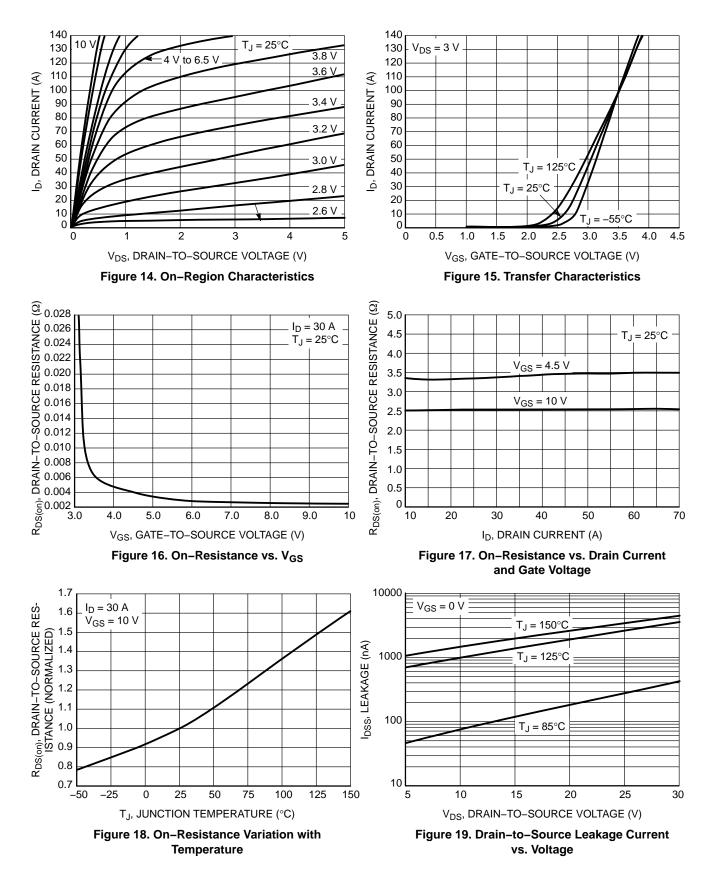


TYPICAL CHARACTERISTICS – Q1



www.onsemi.com 7

TYPICAL CHARACTERISTICS – Q2



TYPICAL CHARACTERISTICS – Q2

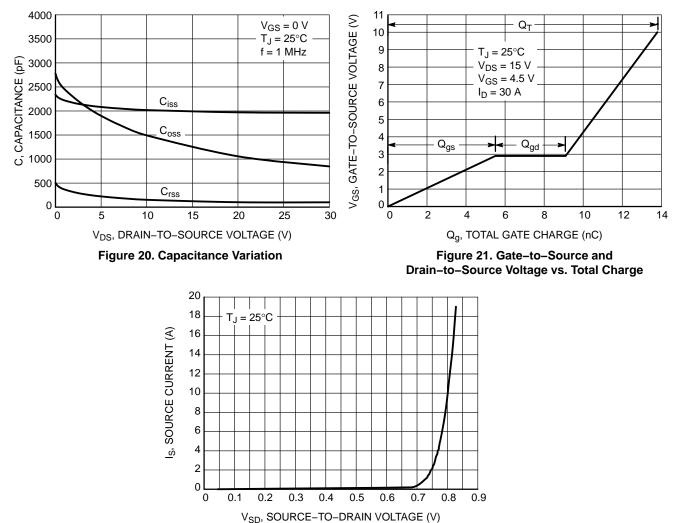


Figure 22. Diode Forward Voltage vs. Current

TYPICAL CHARACTERISTICS – Q2

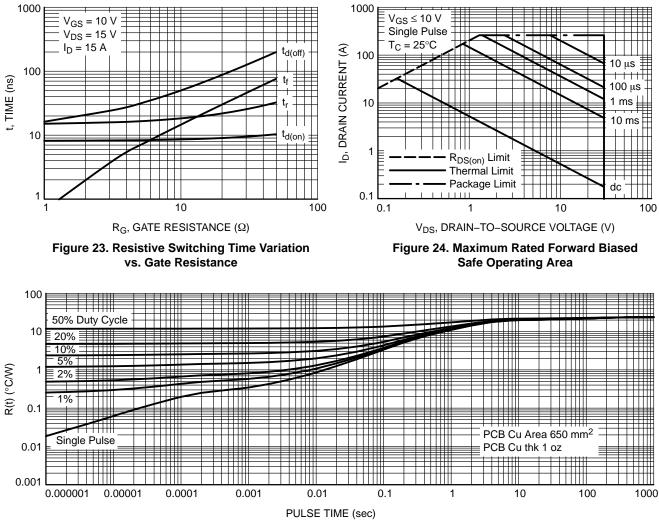


Figure 25. Thermal Characteristics

ORDERING INFORMATION

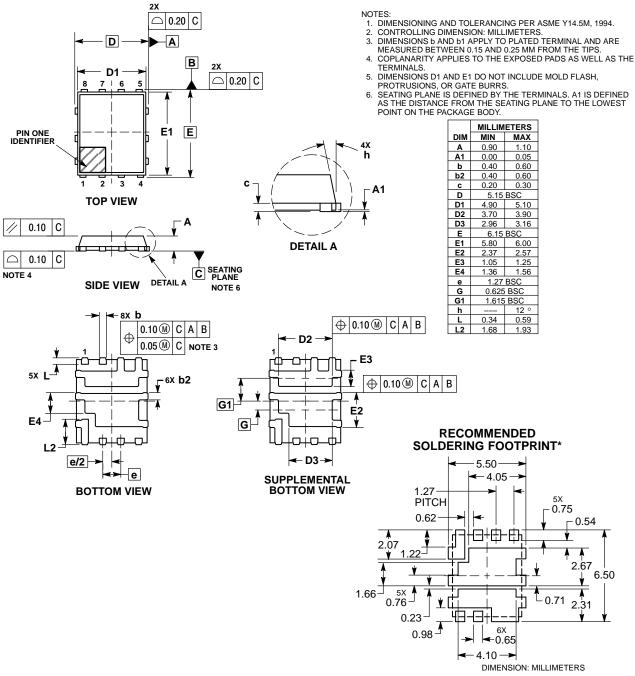
| Device | Package | Shipping [†] |
|---------------|-------------------|-----------------------|
| NTMFD4C87NT1G | DFN8 (Pb–Free) | 1500 / Tape & Reel |
| NTMFD4C87NT3G | DFN8 (Pb–Free) | 5000 / Tape & Reel |

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

DFN8 5x6, 1.27P PowerPhase FET

CASE 506CR ISSUE C



*For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

ON Semiconductor and the in are registered trademarks of Semiconductor Components Industries, LLC (SCILLC) or its subsidiaries in the United States and/or other countries. SCILLC owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of SCILLC's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. SCILLC reserves the right to make changes without further notice to any products herein. SCILLC makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does SCILLC assume any liability arising out of the application or use of any product as here is and/or specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILLC data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters which may be provided in SCILLC data sheets and/or specification by customer's technical experts. SCILLC does not convey any license under its patent rights or the rights of others. SCILLC products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that SCILLC was negligent regarding the design or manufacture of the part. SCILLC is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for reseale

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor P.O. Box 5163, Denver, Colorado 80217 USA Phone: 303–675–2175 or 800–344–3860 Toll Free USA/Canada Fax: 303–675–2176 or 800–344–3867 Toll Free USA/Canada Email: orderlit@onsemi.com N. American Technical Support: 800–282–9855 Toll Free USA/Canada Europe, Midle East and Africa Technical Support:

Phone: 421 33 790 2910 Japan Customer Focus Center Phone: 81–3–5817–1050 ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative

NTMFD4C87N/D